



## High Speed InGaAs p-i-n Photodiode

### 13PD100-TO

The 13PD100-TO, an InGaAs photodiode with a 100 $\mu$ m-diameter photosensitive region packaged in a TO-46 header, is the largest standard device enabling a 1 GHz frequency cutoff. Planar semiconductor design and dielectric passivation provide low noise performance. Reliability is assured by hermetic sealing and 100% purge burn-in ( 200°C, 15 hours,  $V_r = 20V$  ). Chips can also be attached and wire bonded to customer-supplied or other specified packages. Headers are available with either a lensed or flat window cap.

### Features

Planar Structure  
Dielectric Passivation  
100% Purge Burn-In  
High Responsivity

Device Characteristics:						
Parameters	Test Conditions	Min	Typ	Max	Units	
Operating Voltage	-	-	-	-20	Volts	
Dark Current	-5V	-	0.5	2	nA	
Capacitance	-5V	-	1.15	-	pF	
Responsivity	1300nm	0.8	0.90	-	A/W	
Rise/Fall	-	-	-	0.5	ns	
Frequency Response	(-3dB)	-	1.0	-	GHz	
Absolute Maximum Ratings						
Reverse Voltage						30 Volts
Forward Current						10 mA
Reverse Current						500 $\mu$ A
Operating Temperature						-40°C to + 85°C
Storage Temperature						-40°C to + 85°C
Soldering Temperature						250°C

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